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Switchable DBR Filters Using Semiconductor Distributed Doped Areas (ScDDAs)

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Abstract: This paper presents a novel way to switch dual-behavior resonator (DBR) filters without any additional active surface-mount components. By using a semiconductor substrate, we were able to simultaneously co-design the filters and semiconductor distributed doped areas (ScDDAs) with integrated N⁺PP⁺ junctions as active elements. These ScDDAs act as electrical vias in the substrate, which makes it possible to have an open-circuited resonator in the OFF state and a short-circuited resonator in the ON state, and, consequently, to control the transmission zeroes of the filters. This method offers degrees of freedom as the dimensions and positions of these doped areas can be chosen to obtain the best performances. In this study, four filters were simulated and fabricated to spotlight different possibilities for the dimensions and positions of the ScDDA to control the low- or high-frequency transmission zero of the filters. The simulations were in very good agreement with the measured results. All the filters present insertion losses lower than 2 dB in the OFF and ON states, a great flexibility in the frequency choice, and good agility compared with the state of the art.

Keywords: bandpass filter (BPF); co-design; DBR filter; microstrip filter; reconfigurable filter; ScDDA; switchable filter

1. Introduction

In the era of the Internet of Things and Internet of Everything, communication systems are omnipresent. It has never been as complicated as it is today, therefore, to obtain satisfactory tradeoffs between electrical and thermal performances, integrability, and cost. A system has to support increasing numbers of applications and its components such as antennas or filters consequently need reconfigurable functionalities. Filters have to select each desired frequency band related to the targeted applications. There exist many discrete reconfigurable filters making it possible to switch a filter from bandpass to bandstop [1–4], between different bandwidths [5–7] or between different frequency bands, sometimes with multi-states, i.e., with a combination of states of several active elements [8–16]. However, if active surface-mount components (SMCs) such as PIN diodes, RF MEMS or varactor diodes are used to effect such changes, the filters can have issues related to parasitic effects induced by these active components and their associated bias networks. Whole filter performances may thus be decreased by these parasitic effects, which are potentially exacerbated as the frequency increases.

Moreover, while the frequency spectrum becomes increasingly congested, basing filters on dual-behavior resonators (DBR) can provide narrow-band filters [17,18]. Previous studies have shown the interest of making these components tunable [19–22] by using additional lines at the end of each stub, PIN diodes, varactors, or KTN ferroelectric thin-films in order to reach a center frequency agility of up to 32%. However, drawbacks have been reported, like a high control voltage, dependence of the transmission zeroes, and occasional high losses caused by the active SMCs.

In order to counter these issues, reconfigurable RF components can be co-designed using semiconductor distributed doped areas (ScDDAs), such as in [23–27]. By designing a tunable RF device with ScDDAs, we can obtain a tunability comparable to that of classical technology with SMCs while avoiding the need for other components. Indeed, ScDDAs are semiconductor junctions acting as electrical vias in the substrate thickness, i.e., they are integrated active components in the substrate. This method offers flexibility in terms of dimensions and positions of the active elements and avoids the drawbacks of adding SMCs.

In this context, the aim of the present paper is to propose narrow-band filters such as DBR ones using ScDDAs. This offers filter designers more possibilities for the control of the frequency zeroes and means to achieve good tradeoffs in terms of electrical performances, integrability, and cost.

In this paper, Section 2 deals with the switchable DBR concept. Then, Section 3 explains the co-simulation method and the measured results on a first demonstrator. Finally, in Section 4, the flexibility and degrees of freedom are discussed and compared with the state of the art and three other DBRs.

2. Switchable DBR Theory

DBRs are based on the parallel association of two bandstop structures that can be two open-ended stubs, a quarter wavelength long, at a specific frequency (Figure 1a). Each resonator has its own specific length to give a transmission zero. By appropriately selecting these transmission zeroes (TZ), a bandpass filter can be obtained.

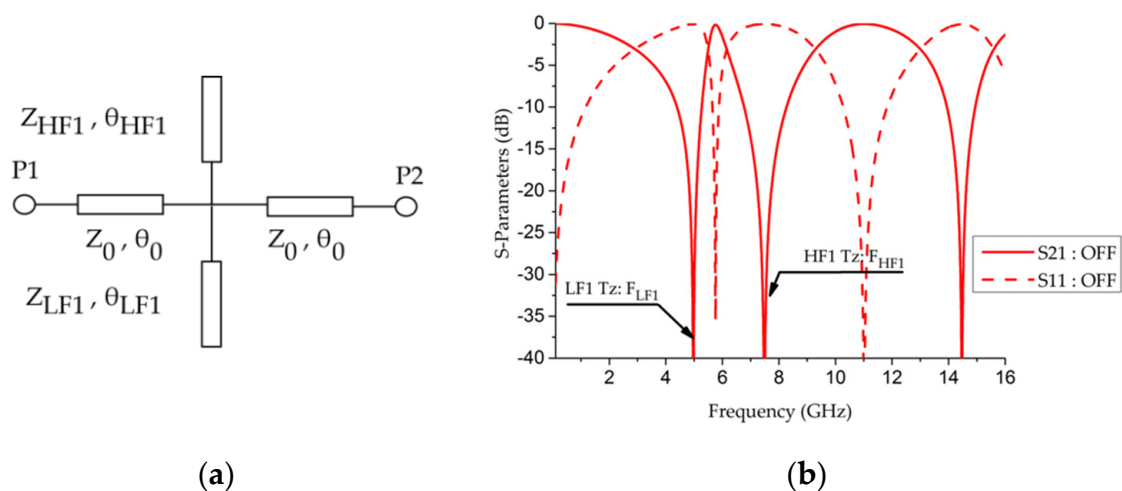


Figure 1. (a) Dual behavior resonator (DBR) design in the OFF state with two open-ended stubs linked to the two frequencies LF_1 and HF_1 ; (b) example of simulated results with the two transmission zeroes for a central frequency of 5.6 GHz.

Thus, the longer resonator in Figure 1a is for the low-frequency (LF_1) transmission zero and the shorter one is for the high-frequency (HF_1) transmission zero. Figure 1b shows an example of simplified simulated results, i.e., without end effects or dielectric losses, obtained using the Advanced Design Systems (ADS) electronics software from Keysight Technologies©, where the two TZ make a 5.7 GHz bandpass filter possible. Then, if one resonator is short-circuited, this modifies the transmission zero and, consequently, the central frequency of the bandpass filter.

By using one active element, there are two alternative ways to create a switchable DBR. The first option is to short-circuit a stub as shown in Figure 2a; the LF transmission zero LF_1 becomes LF_2 , thus modifying the central frequency from 5.7 GHz to 3.2 GHz (Figure 2b) in the OFF and ON states, respectively. The second option is to short-circuit the high-frequency resonator (Figure 3a); the high-frequency transmission zero HF_1 becomes HF_2 , which makes it possible to switch the central frequency from 5.7 GHz in the OFF state to 2.5 GHz in the ON state (Figure 3b).

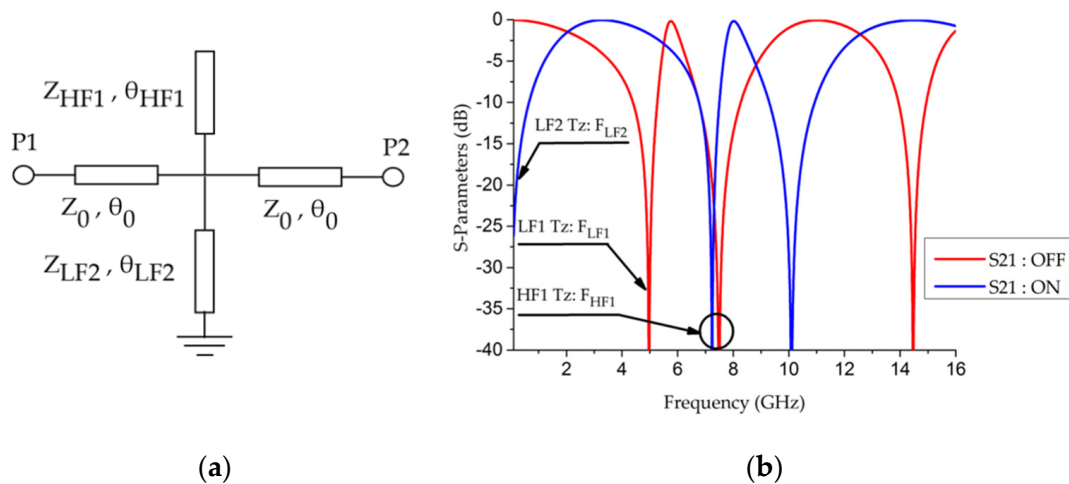


Figure 2. (a) DBR design in the ON state with the LF_2 stub short-circuited and the HF_1 stub open-circuited; (b) Example of simulated results for central frequencies of 5.7 GHz in the OFF state and 3.2 GHz in the ON state.

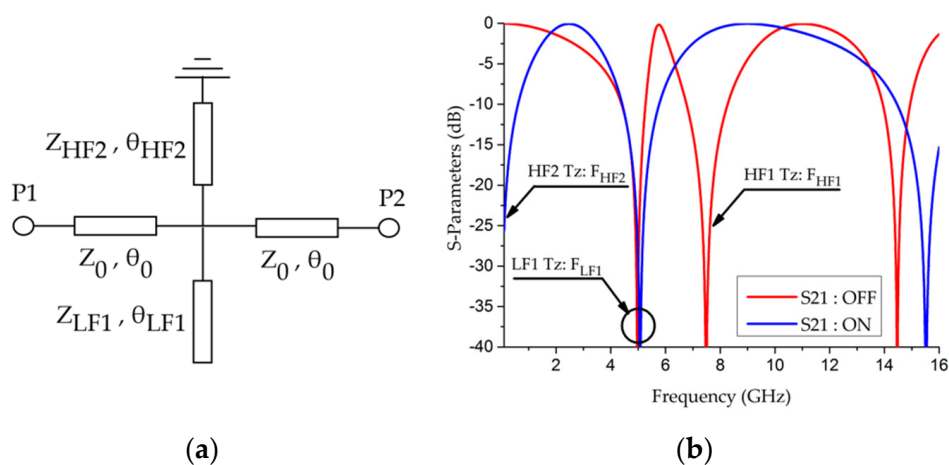


Figure 3. (a) DBR design in the ON state with the LF_1 stub open-circuited and the HF_2 stub short-circuited; (b) Example of simulated results for central frequencies of 5.7 GHz in the OFF state and 2.5 GHz in the ON state.

3. Switchable DBR Demonstrator

Based on the switchable DBR concept, our objective here was to co-design a DBR and its active element on a high-resistivity silicon (HR-Si) substrate. Indeed, a high resistivity was chosen to minimize the losses of the propagating waves in the substrate. Furthermore, the advantage of using this kind of substrate, i.e., a semiconductor, is that it makes it possible to design transmission lines and ScDDAs at the same time and thus to co-design a switchable DBR. We can, therefore, optimize electrical performances of the two states and enhance the integrability by using a low-cost technology compatible with mass-production.

3.1. Design and Modeling

A P-type silicon substrate was chosen with a 675 μm thickness and doped with boron with a resistivity of 2500 $\Omega\cdot\text{cm}$. The active element was an N^+PP^+ junction with a surface doping of around 3×10^{19} atoms/ cm^3 for the two N^+ and P^+ regions and doping depths of around 3 μm . Figure 4 shows the switchable DBR design with its integrated active element, located at the end of the HF resonator. The length \times width dimensions of the low- and high-frequency stubs are noted $L_{\text{stub}_{\text{HF}}} \times W_{\text{HF}}$ and $L_{\text{stub}_{\text{LF}}} \times W_{\text{LF}}$, respectively, and the dimensions of the doped area are noted $L_{\text{DOP}} \times W_{\text{DOP}}$. The lengths and widths of the two resonators were calculated to obtain a low-frequency transmission zero at 4.8 GHz and a high-frequency transmission zero at 7.2 GHz, based on the synthesis in [17]. The access line widths were dimensioned to have a 50 Ω characteristic impedance and their lengths were chosen to be sufficiently long to be easily measured. The DBR dimensions are listed in Table 1.

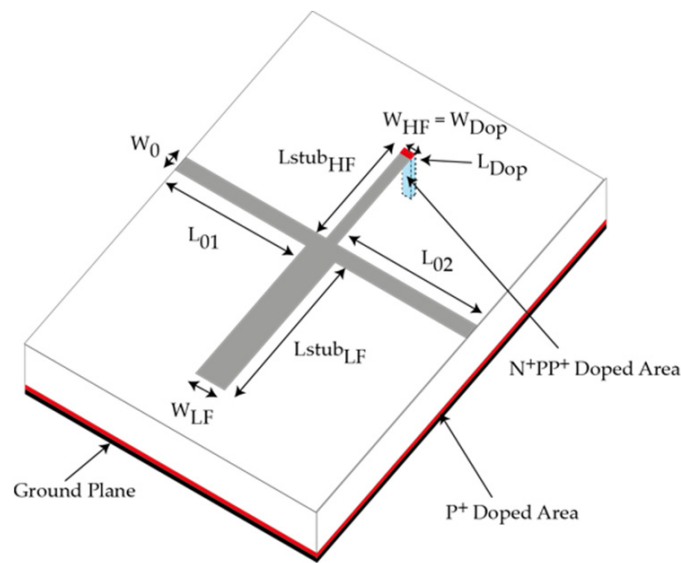


Figure 4. 3-D diagram of the switchable DBR₁ demonstrator.

Table 1. Dimensions of Switchable DBR₁.

	Access	LF Resonator	HF Resonator	ScDDAs
Length	$L_{01} = 3.74$ mm $L_{02} = 4$ mm	$L_{\text{stub}_{\text{LF}}} = 5.46$ mm	$L_{\text{stub}_{\text{HF}}} = 3.8$ mm	$L_{\text{Dop}} = 0.2$ mm
Width	$W_0 = 0.56$ mm	$W_{\text{stub}_{\text{LF}}} = 0.84$ mm	$W_{\text{stub}_{\text{HF}}} = 0.31$ mm	$W_{\text{Dop}} = 0.31$ mm

This demonstrator was simulated using an HFSSTM electromagnetic simulator to predict its behavior. The semiconductor losses were taken into account using the substrate resistivity in the calculation loss tangent as follows:

$$\tan\delta = \frac{1}{\rho\omega\epsilon_0\epsilon_r} + 0.0018 \quad (1)$$

where ρ is the resistivity, ω is equal to $2\pi\text{freq}$, ϵ_0 is the vacuum dielectric permittivity and ϵ_r is the silicon dielectric permittivity, equal to 11.9.

The active element was simulated using two 3 μm deep layers of 7.1×10^5 S/m conductivity, corresponding to the conductivity of heavily doped areas. Between these two layers, i.e., between the top and the bottom sides, within the substrate itself, a resistivity of 2500 $\Omega\cdot\text{cm}$ in the OFF state and a resistivity of 0.1 $\Omega\cdot\text{cm}$ in the ON state, which was estimated using AtlasTM from Silvaco[©] when the junction was forward biased. Figure 5 presents the electromagnetic simulated results of the switchable

DBR₁ demonstrator in OFF and ON states. In the OFF state, the two transmission zeroes at 4.8 GHz and 7.2 GHz make it possible to obtain a bandpass filter at 5.52 GHz. When the N⁺PP⁺ is simulated in forward bias, the high-frequency transmission zero is switched to DC allowing a transmission frequency band at 2.44 GHz. The simulated insertion losses are 0.9 dB at 5.52 GHz in the OFF state and 2.01 dB at 2.44 GHz in the ON state.

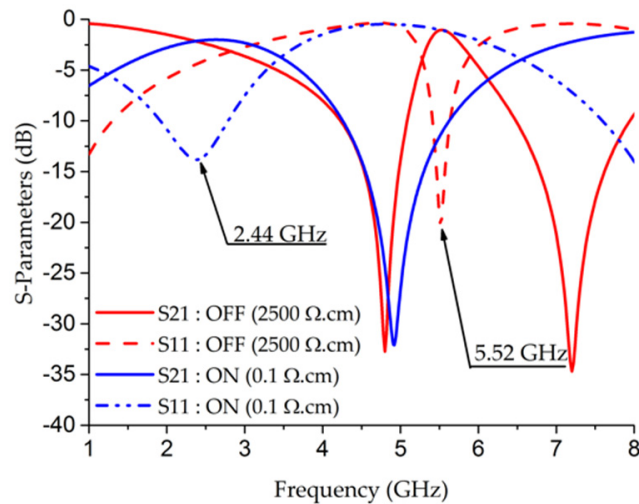


Figure 5. HFSSTM-simulated results of switchable DBR₁ in the OFF and ON states.

3.2. Fabrication and Measurements

This demonstrator was fabricated with only two masks: one for the doping steps and one for the metallization steps of the upper side. The manufacturing steps are detailed in [27].

Figure 6 shows a photograph of the switchable DBR₁ demonstrator, placed between two SMA connectors for measurement. The two RF cables and DC source were connected to an R&S[®] ZVA 67 Vector Network Analyzer (VNA). The DC bias voltage was applied with the RF signal. Because the DC ground was connected to the RF ground, a negative voltage was required to forward bias the N⁺PP⁺ junction. A Short Open Load through (SOLT) calibration was performed to remove the losses of the cables but not the losses from the SMA connectors.

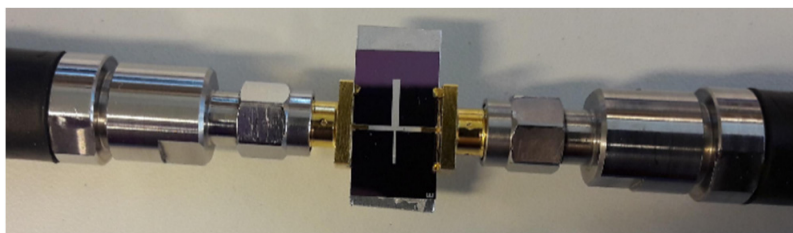


Figure 6. Photograph of switchable DBR₁.

The measured results are presented in Figure 7. In the OFF state, with a zero-bias voltage, the two transmission zeroes are measured at 4.83 GHz and 7.2 GHz, which implies a central frequency at 5.58 GHz with an insertion loss level of 1.97 dB. In the ON state, the lowest frequency transmission zero stays relatively constant, whereas the high-frequency transmission zero is moved to the DC frequency so the central frequency is switched to 2.55 GHz with a bias voltage of -1.5 V. The insertion loss level is then 1.9 dB.

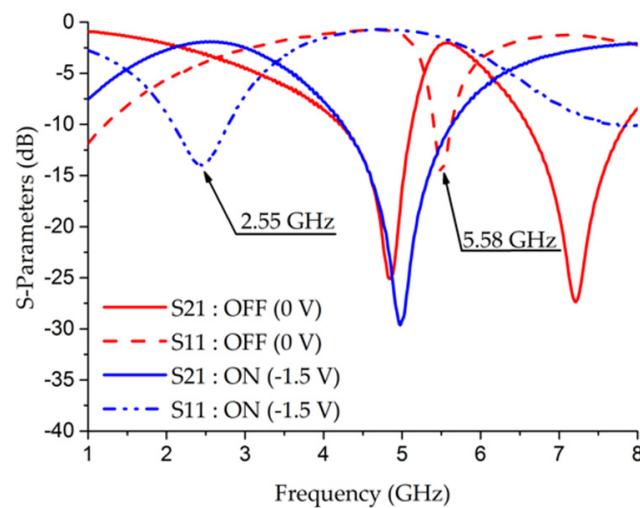


Figure 7. Measured results of switchable DBR₁ in the OFF and ON states.

Figure 8a,b show comparisons of the simulated and measured results in the OFF and ON states. A good agreement was obtained overall, with slight differences that could be due to the substrate resistivity (given by the manufacturer as between 1 k Ω ·cm and 10 k Ω ·cm), the SMA connector losses themselves and the losses related to connection defects, i.e., the gap that exists between the connector and the substrate because these are separate elements.

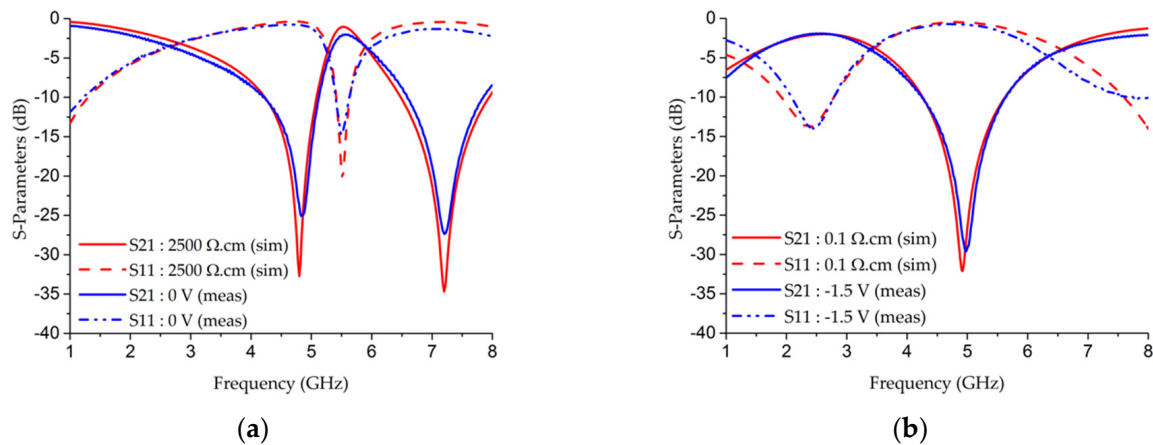


Figure 8. Comparison of simulated and measured results of switchable DBR₁. (a) in the OFF state; (b) in the ON state.

4. Discussion

The co-design approach used in the present study offers great flexibility and accuracy for the dimensioning and positioning of the doped areas, thanks to the semiconductor process. In order to show an overview of the possibilities, three other demonstrators (Figure 9) with different doped lengths and widths were designed and characterized. These switchable DBRs had the same metal layout as the first demonstrator DBR₁, only the dimensions (listed in Table 2) of the doped areas (located at the end of the resonator) were modified.

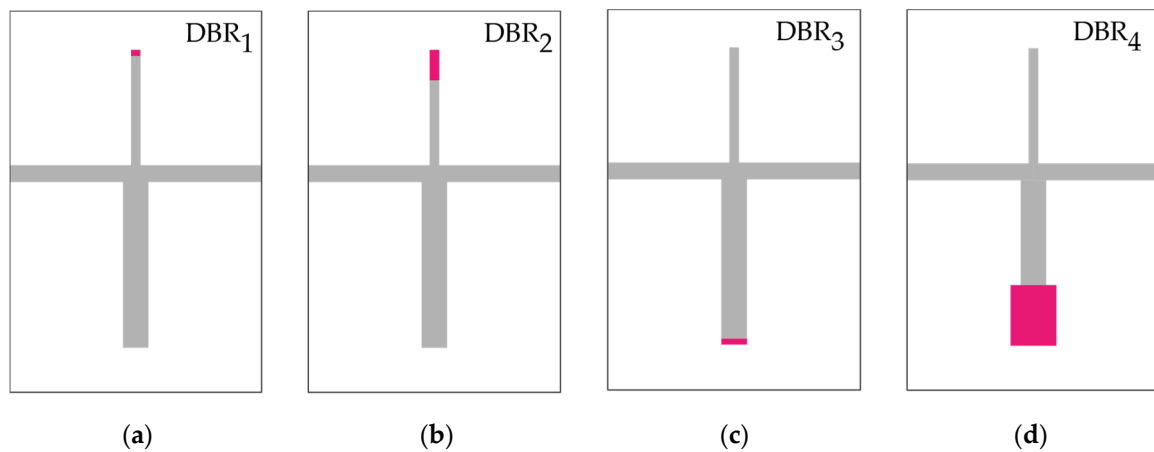


Figure 9. Top views of switchable DBRs. (a) DBR₁ with doped area dimensions of 0.2 mm × 0.314 mm. (b) DBR₂ with doped area dimensions of 1 mm × 0.314 mm. (c) DBR₃ with doped area dimensions of 0.2 mm × 0.836 mm. (d) DBR₄ with doped area dimensions of 2 mm × 1.5 mm. Measured results of switchable DBR₁ in the OFF and ON states.

Table 2. Dimensions of the ScDDAs of the four demonstrators.

	ScDDA of DBR ₁	ScDDA of DBR ₂	ScDDA of DBR ₃	ScDDA of DBR ₄
Length	L _{Dop} = 0.2 mm	L _{Dop} = 1 mm	L _{Dop} = 0.2 mm	L _{Dop} = 2 mm
Width	W _{Dop} = 0.31 mm	W _{Dop} = 0.31 mm	W _{Dop} = 0.84 mm	W _{Dop} = 1.5 mm

Figure 10a,b show comparisons of the simulated and measured results of switchable DBR₂ in the OFF and ON states. As for DBR₁, a good agreement was obtained overall. It has a longer ScDDA than DBR₁ on the HF stub, with 1 mm length. Therefore, compared with DBR₁, the central frequency is the same in the OFF state, i.e., equal to 5.53 GHz, with a 0 V bias voltage. The insertion loss level is 1.97 dB. In the ON state, with a −1.2 V bias voltage, the highest transmission zero is moved to DC and the transmission frequency band is at 2.6 GHz, with an insertion loss level of 1.95 dB. The bias voltage is lower than for DBR₁ because the doped area is longer.

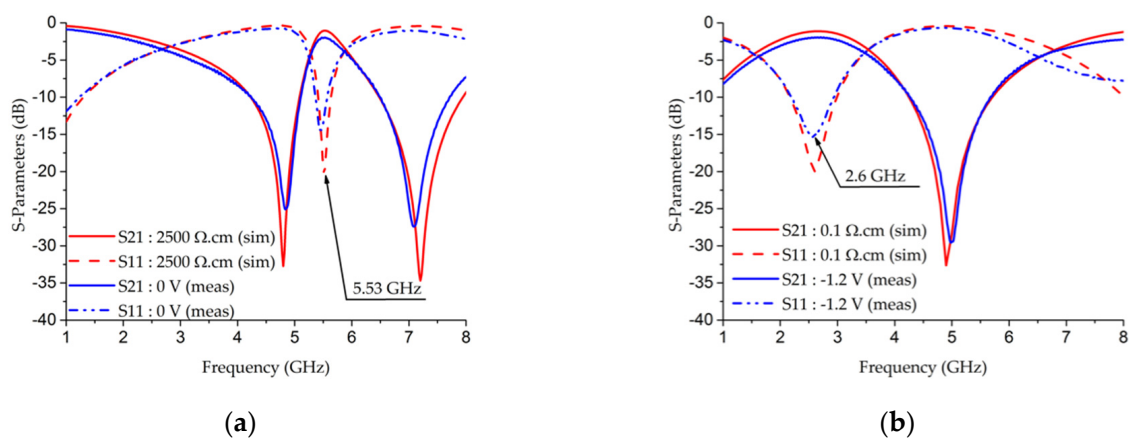


Figure 10. Comparison of simulated and measured results of switchable DBR₂. (a) in the OFF state; (b) in the ON state.

Switchable DBR₃ has an ScDDA with a doped length of 0.2 mm, located at the end of the LF resonator. Figure 11a,b show comparisons of the simulated and measured results of switchable DBR₃ in the OFF and ON states. These figures show a commutation in the central frequency from 5.53 GHz

in the OFF state, with a 0 V bias voltage, to 3.23 GHz in the ON state, with a -1.5 V bias voltage. The insertion loss levels are 1.98 dB and 1.68 dB, respectively.

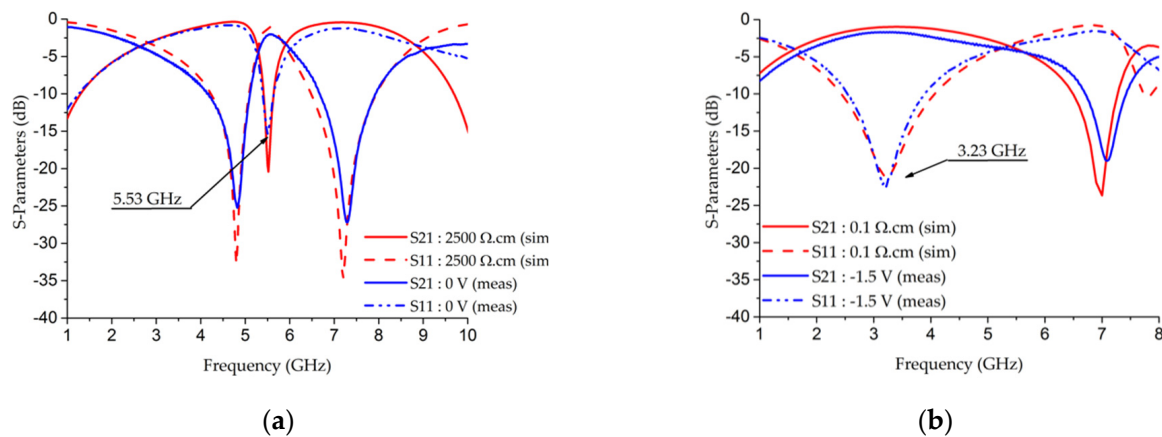


Figure 11. Comparison of simulated and measured results of switchable DBR₃. (a) in the OFF state; (b) in the ON state.

The last demonstrator, DBR₄, has a wider and longer ScDDA than DBR₃. This implies a capacitive effect in the OFF state, which explains why the resonant frequency, at 5.2 GHz, is lower than for the other demonstrators (Figure 12a). It also has a shorter resonator in the ON state, which gives a resonant frequency of 3.8 GHz in the ON state (higher than with DBR₃) (Figure 12b), with a bias voltage of -1 V. The insertion losses are 1.94 dB and 1.95 dB in the OFF and ON states, respectively.

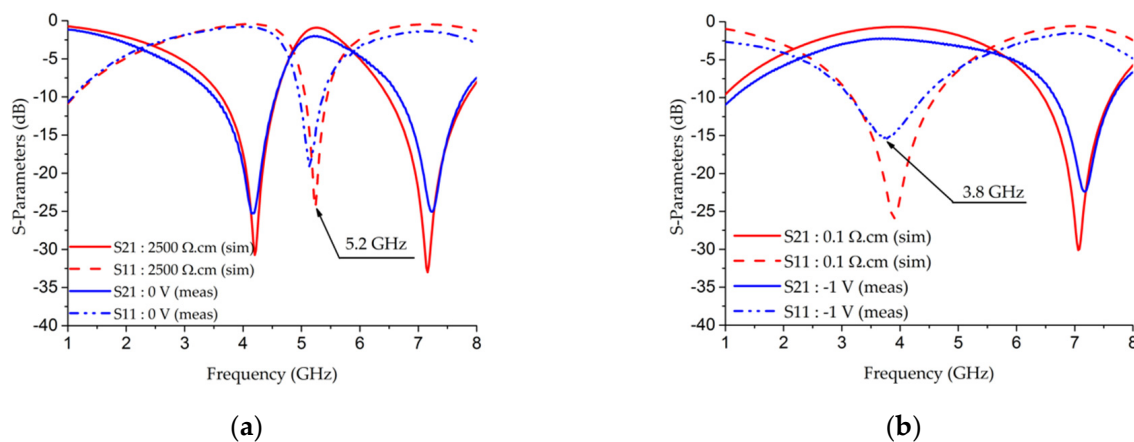


Figure 12. Comparison of simulated and measured results of switchable DBR₄. (a) in the OFF state; (b) in the ON state.

Moreover, with a 5.52 GHz filter in the OFF state, the central frequency in the ON state can be selected between 2.44 GHz and 5 GHz by choosing the length of the doped area and short-circuiting the LF- or HF- stub (Figure 13). The ratio can be between 1:1.1 and 1:2.25, which offers many possibilities depending on the application. The greater the doped area surface, the lower the bias voltage. Thus, if the bias voltage is not an issue, the size can be minimized while maintaining the switched frequency. This can be a good solution in the case of multiple states, such as in [25].

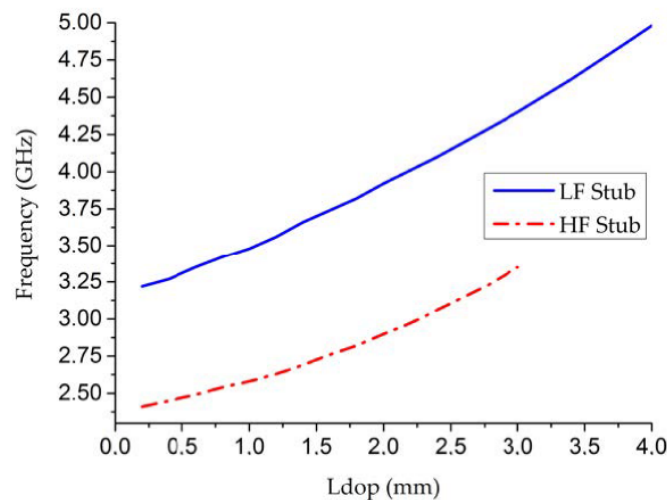


Figure 13. Central frequency of a switchable DBR in the ON state depending on the doped area length, for a central frequency of 5.52 GHz in the OFF state.

Table 3 shows a comparison between the state-of-the-art and the results of the present study. Our work shows a great agility, with the best tradeoff between the highest frequency ratio and good performances, i.e., low losses, without any additional components.

Table 3. Comparison between previous two-state switchable filters and this work.

Ref.	Freq. (GHz) LF Band	Freq. (GHz) HF Band	IL (dB) LF Band	IL (dB) HF Band	Active Components	Frequency Ratio
[8]	1.94	2.43	3.84	3.35	PIN diodes	1:1.25
[9]	1.06	1.51	1.7	1.7	PIN diodes	1:1.42
[10]	1.92	2.08	3.94	3.07	PIN diodes	1:1.08
[10]	2.03	4.47	24.46	3.77	PIN diodes	1:2.2
[11]	2.53	4.9	3.77	2.64	PIN diodes	1:1.94
[12]	1.2	1.5	2.1	2.21	PIN diodes	1:1.25
[13]	0.90	1.25	1.8	1.9	PIN diodes	1:1.38
[14]	3.7	4	2.6	2.6	Vanadium-di-oxide	1:1.08
This study DBR ₁	2.55	5.58	1.97	1.9	Integrated ScDDA	1:2.19
This study DBR ₂	2.6	5.53	1.97	1.95	Integrated ScDDA	1:2.13
This study DBR ₃	3.23	5.53	1.98	1.68	Integrated ScDDA	1:1.71
This study DBR ₄	3.8	5.2	1.94	1.95	Integrated ScDDA	1:1.37

Although devices of this kind present measurement difficulties due to their fragility and size and, therefore, require measurement by SMA connectors without the possibility of soldering, the devices tested here show good performances in both states, with the same losses overall. Indeed, in the ON state, even though the demonstrators have different surface areas, their equivalent resistance values can be roughly the same with different bias voltages.

5. Conclusions

This paper shows a novel method for switching DBR filters without any additional components. Four demonstrators were characterized, offering a large range of reconfigurability without sacrificing performances, i.e., a low switching voltage, low losses, and a high level of integrability, all obtained with a well-known manufacturing process (the same as for semiconductor components), with a reduced

number of masks and steps. Such a co-design offers flexibility in terms of positioning and dimensioning of the ScDDAs, which implies a good agility, with a large range of choice for the ratio: between 1:1.1 and 1:2.25.

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Conflicts of Interest: The authors declare no conflict of interest.

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